

DESCRIPTION

The SSF3341L uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

• $V_{DS} = -30V, I_{D} = -4.2A$

 $R_{DS(ON)}$ < 120m Ω @ V_{GS} =-2.5V

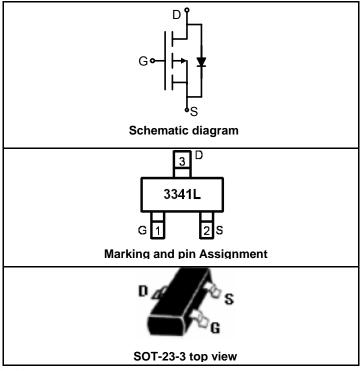
 $R_{DS(ON)} < 65 \text{m}\Omega @ V_{GS} = -4.5 \text{V}$

 $R_{DS(ON)} < 50 \text{m}\Omega$ @ V_{GS} =-10V

- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- ●PWM applications
- ●Load switch
- Power management



PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
3341L	SSF3341L	SOT-23-3	Ø180mm	8 mm	3000 units

ABSOLUTE MAXIMUM RATINGS(TA=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-30	V
Gate-Source Voltage	V _G s	±12	V
	I _D (25℃)	-4.2	А
Drain Current-Continuous@ Current-Pulsed (Note 1)	I _D (70℃)	-3.5	А
	I _{DM}	-30	А
Maximum Power Dissipation	P _D	1	W
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}\!\mathbb{C}$

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2) R _{BJA} 90 °C/
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ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-24V,V _{GS} =0V			-1	μΑ
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±12V,V _{DS} =0V			±100	nA



ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-0.7		-2	V	
		V _{GS} =-10V, I _D =-4.2A		42	50		
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-4A		53	65	$\boldsymbol{m}\Omega$	
		V _{GS} =-2.5V, I _D =-1A		80	120	20	
Forward Transconductance	9 FS	V_{DS} =-5 V , I_{D} =-5 A		10		S	
DYNAMIC CHARACTERISTICS (Note4)							
Input Capacitance	C_{lss}			950		PF	
Output Capacitance	C _{oss}	V _{DS} =-15V,V _{GS} =0V, F=1.0MHz		120		PF	
Reverse Transfer Capacitance	C _{rss}			70		PF	
SWITCHING CHARACTERISTICS (Note 4	4)						
Turn-on Delay Time	t _{d(on)}			6.5		nS	
Turn-on Rise Time	t _r	V _{DD} =-15V,I _D =-3.2A		3		nS	
Turn-Off Delay Time	t _{d(off)}	V_{GS} =-10V, R_{GEN} =6 Ω		30		nS	
Turn-Off Fall Time	t _f	1		12		nS	
Total Gate Charge	Qg			9.6		nC	
Gate-Source Charge	Q _{gs}	V _{DS} =-15V,I _D =-4A,V _{GS} =-4.5V		2		nC	
Gate-Drain Charge	Q_{gd}			2.6		nC	
DRAIN-SOURCE DIODE CHARACTERIST	rics	•	1				
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-1A			-1.2	V	

NOTES:

- Repetitive Rating: Pulse width limited by maximum junction temperature.
 Surface Mounted on 1in² FR4 Board, t ≤ 10 sec.
 Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

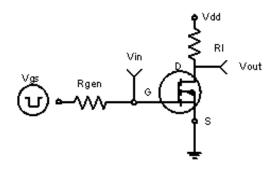


Figure 1:Switching Test Circuit

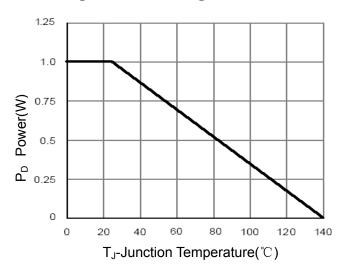


Figure 3 Power Dissipation

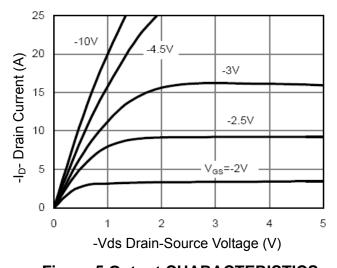


Figure 5 Output CHARACTERISTICS

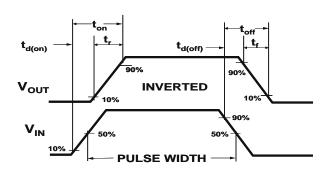


Figure 2:Switching Waveforms

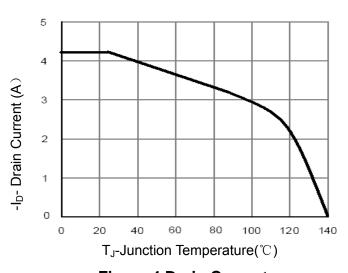


Figure 4 Drain Current

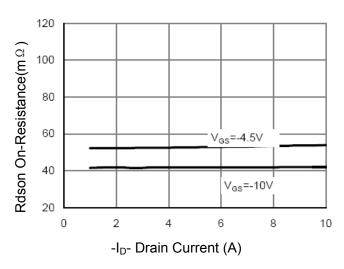


Figure 6 Drain-Source On-Resistance



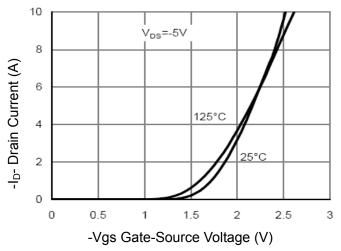


Figure 7 Transfer Characteristics

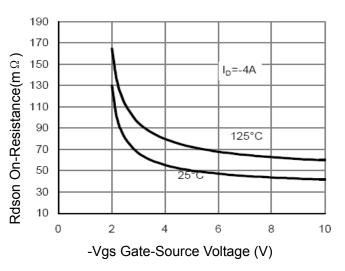


Figure 9 Rdson vs Vgs

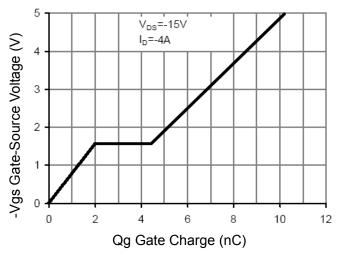


Figure 11 Gate Charge

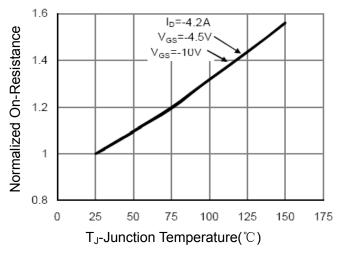


Figure 8 Drain-Source On-Resistance

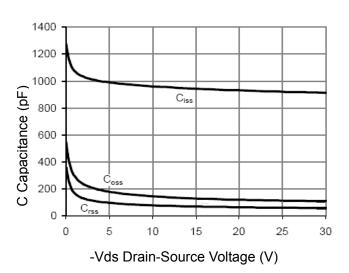


Figure 10 Capacitance vs Vds

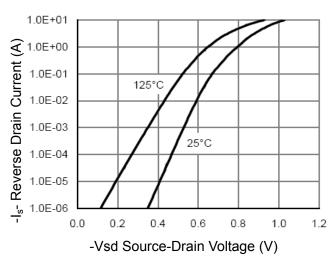


Figure 12 Source- Drain Diode Forward



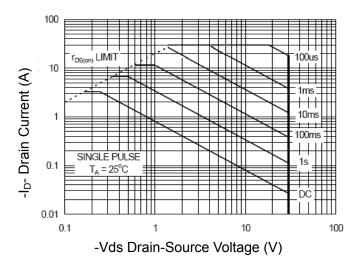
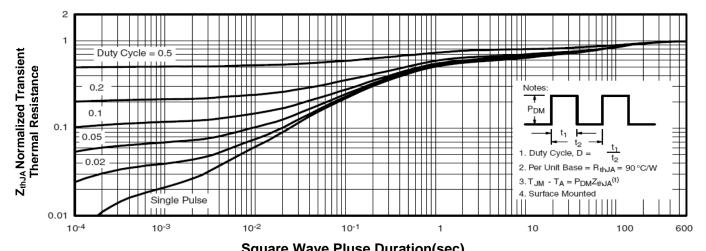


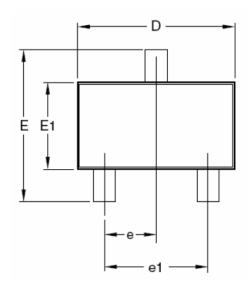
Figure 13 Safe Operation Area

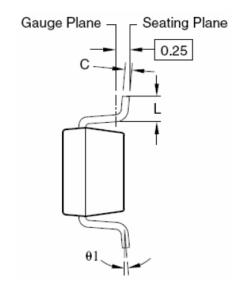


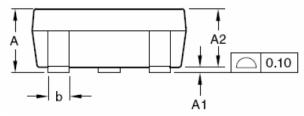
Square Wave Pluse Duration(sec)
Figure 14 Normalized Maximum Transient Thermal Impedance



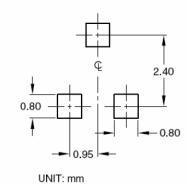
SOT23-3 PACKAGE INFORMATION







RECOMMENDED LAND PATTERN



Dimensions in millimeters

Symbols	Min.	Nom.	Max.		
Α	0.90	_	1.25		
A1	0.00	_	0.13		
A2	0.70	1.00	1.15		
b	0.30	0.40	0.50		
С	0.08	0.13	0.20		
D	2.80	2.90	3.10		
E	2.60	2.80	3.00		
E1	1.40	1.60	1.80		
е	(
e1	1.90 BSC				
L	0.30	_	0.60		
θ1	0°	5°	8°		

Dimensions in inches

Symbols	Min.	Nom.	Max.			
Α	0.035	_	0.049			
A1	0.000	_	0.005			
A2	0.028	0.039	0.045			
b	0.012	0.016	0.020			
С	0.003	0.005	0.008			
D	0.110	0.114	0.122			
Е	0.102	0.110	0.118			
E1	0.055	0.063	0.071			
е	0.037 BSC					
e1	0.075 BSC					
L	0.012	_	0.024			
θ1	0°	5°	8°			

NOTES:

- 1. Tolerance ± 0.10 mm (4 mil) unless otherwise specified
- 2. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- Dimension L is measured in gauge plane.
 Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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